

# Search Notes



Application/Control No.

09/929,223

Examiner

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Applicant(s)/Patent under Reexamination

AUBERTIN ET AL.

Art Unit

3629

## SEARCHED

Class	Subclass	Date	Examiner
705	1	9/05	DN
	26	↓	
709	206		

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
I US	9/05	DN
Patent BG Pub	↓	↓
II FOREIGN		
1. EPO 2. JPO 3. Derwent		
III NPL		
1. Flex1 2. Flex2 3. NFflex	↓	↓